Notice of References Cited

| Application/Control No. 10/052,220 | Applicant(s)/Patent Under Reexamination O'HAGAN, DAVID | | |
|------------------------------------|--|-------------|--|
| Examiner | Art Unit | | |
| Jeffrey R. Snay | 1743 | Page 1 of 1 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | Α | US-4,168,460 | 09-1979 | Menke, Everhard | 324/71.1 |
| | В | US-6,165,778 | 12-2000 | Kedar, Haim | 435/289.1 |
| | C | US-6,429,027 | 08-2002 | Chee et al. | 436/518 |
| | D | US-6,730,515 | 05-2004 | Kocher, Thomas E. | 436/8 |
| | E | US-2003/0003516 | 01-2003 | Robinson et al. | 435/7.9 |
| | F | US-2003/0040129 | 02-2003 | Shah, Haresh P. | 436/526 |
| | G | US-6,458,165 | 10-2002 | Foucher et al. | 359/296 |
| | Н | US-2004/0048311 | 03-2004 | Ault-Riche et al. | 435/007.1 |
| | ı | US-5,483,469 | 01-1996 | Van den Engh et al. | 702/21 |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------------|----------------|
| | N | WO 00/16101 | 03-2000 | WIPO | Walt et al | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.